

**Search Notes**

Application/Control No.

10/667,675

Examiner

Jim Vannucci

Applicant(s)/Patent under  
Reexamination

ANIKITCHEV ET AL.

Art Unit

2828

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
same as above		11/9/2005	JV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
372/101, 359/619, slow axis, fast axis, micro-lens	11/9/2005	JV